

A Complete Bibliography of Publications in *Technometrics* for the decade 1960–1969

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Title word cross-reference

2 [DT68]. 2^{17-9} [Add65, Pre66]. 2^{k-p} [BH61a, BH61b]. 2^n
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[Har66]. t [DT68, GB65, Hal63, Kra66b, Owe68]. T^2 [JB61]. U [Sho67b]. V
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3 [BCK78, Hay68, Luk64a].

4 [Luk64b].

5 [Ter65].

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Variance [And65, Boc63, BA63, CR66, Gla62, HH69, JL69, Koc67a, Koc68,
KA67, LNJE68, Man64a, NH69, Owe65b, SV69, TM63, Tuk61, ZT68, LN66,
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Vertices [Dia67, Gor66, MA66]. **Victor** [Coh66a]. **Viewpoint** [Gei66].
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[Bar63c, Coo66, Hay68, Luk64a, Luk64b, McK69d, Par64, Pfa63a, Sam69].
Volume [All63, Ano60j, Ano61l, Ano62l, Ano63n, Ano64m, Ano65p, Ano66o,
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